## metal-organic papers

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#### **Key indicators**

Single-crystal X-ray study T = 173 K Mean  $\sigma$ (C–C) = 0.004 Å R factor = 0.036 wR factor = 0.098 Data-to-parameter ratio = 17.2

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

# 5,5-Dimethyl-2,2-bis(pentafluorophenyl)-4,4,6,6-tetrakis(trimethylsilyl)-1,3-dioxa-4,5,6-trisila-2-titanacyclohexane

The title compound,  $[Ti(C_6F_5)_2(C_{14}H_{42}O_2Si_7)]$ , was readily synthesized from  $B(C_6F_5)_3$  and  $SiMe_2[(Me_3Si)_2SiO]_2TiMe_2$  in *n*-pentane. The compound contains one titanium metal centre with a distorted tetrahedral geometry.

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### Comment

We have investigated the reactivity of compound (1) (see scheme) towards the Lewis acid  $B(C_6F_5)_3$  that is known to abstract alkyl groups from the metal centre to form cationic metal species active in olefin polymerization. Complex (1) reacted cleanly with  $B(C_6F_5)_3$  (molar ratio 1:1) within minutes, resulting in the formation of  $Me_2Si[(Me_3Si)_2SiO]_2Ti(C_6F_5)_2$ , (2), the quantitative product of  $C_6F_5$  group transfer. The fact that both methyl groups have been replaced smoothly by  $C_6F_5$  groups indicates the high electrophilicity of the titanium centre caused by the electron-withdrawing ligand environment.



The structure of (2) contains a titanium centre with a distorted tetrahedral coordination geometry (Fig. 1 and Table 1). The titanium is coordinated in a chelate fashion  $[O1-Ti1-O2\ 106.33\ (7)^\circ]$  by the siloxide ligand, giving a nearly planar six-membered ring. The Ti-O distances  $[1.7503\ (15)$ , 1.7408 (15) Å] in the ring are similar to those found in closely related cyclic siloxide complexes (Krempner *et al.*, 2006).

## **Experimental**

All manipulations were carried out under an atmosphere of argon using standard Schlenk and glove-box techniques. Benzene- $d_6$  was dried over activated molecular sieves and stored in the glove box and *n*-pentane was distilled under argon from alkali metals prior to use. B(C<sub>6</sub>F<sub>5</sub>)<sub>3</sub> (Chernega *et al.*, 1997) and (1) (Krempner *et al.*, 2006) were prepared as previously described. NMR: Bruker AC 250. A Schlenk flask was charged with (1) (0.28 g, 0.54 mmol) and B(C<sub>6</sub>F<sub>5</sub>)<sub>3</sub> (0.27 g, 0.52 mmol) and dissolved in *n*-pentane (10 ml) at *ca* 253K. The stirred yellow solution was allowed to warm to room temperature within 30 min, after which time the solution was concentrated. Crystallization at 233K afforded SiMe<sub>2</sub>[(Me<sub>3</sub>Si)<sub>2</sub>SiO]<sub>2</sub>Ti(C<sub>6</sub>F<sub>5</sub>)<sub>2</sub> (2) as orange crystals [yield 0.18 g (41%); m.p. 395–396K]. <sup>1</sup>H-NMR (C<sub>6</sub>D<sub>6</sub>, 250 MHz): *d* = 0.41 (*s*, Si(CH<sub>3</sub>)<sub>2</sub>, 6 H), 0.21 (*s*, Si(CH<sub>3</sub>)<sub>3</sub>, 36 H) p.p.m.. <sup>13</sup>C-NMR (C<sub>6</sub>D<sub>6</sub>, 75.5 MHz): *d* = -0.7 (Si(CH<sub>3</sub>)<sub>3</sub>), -1.1 (Si(CH<sub>3</sub>)<sub>2</sub>),

© 2007 International Union of Crystallography All rights reserved 134,4–149,6 (C<sub>6</sub>F<sub>5</sub>) p.p.m. <sup>29</sup>Si-NMR (C<sub>6</sub>D<sub>6</sub>, 59.6 MHz): d = 34.4 (SiO), -11.7 (Si(CH<sub>3</sub>)<sub>3</sub>), -28.5 (Si(CH<sub>3</sub>)<sub>2</sub>) p.p.m. <sup>19</sup>F (235.4 MHz): d = 158.8, -146.8, -116.6 (*m*-, *p*-, *o*-F, Ti(C<sub>6</sub>F<sub>5</sub>)<sub>2</sub>) p.p.m. Analysis calculated for C<sub>26</sub>H<sub>42</sub>F<sub>10</sub>O<sub>2</sub>Si<sub>7</sub>Ti (821.07): C, 38.03; H 5.16%. Found: C, 34.79; H 5.04%.

Z = 4

 $D_r = 1.306 \text{ Mg m}^{-3}$ 

 $0.60 \times 0.48 \times 0.45 \text{ mm}$ 

7359 independent reflections

 $w = 1/[\sigma^2(F_o^2) + (0.0379P)^2]$ 

where  $P = (F_0^2 + 2F_c^2)/3$ 

+ 3.8726P]

 $\Delta \rho_{\rm max} = 0.59 \ {\rm e} \ {\rm \AA}^{-3}$ 

 $\Delta \rho_{\rm min} = -0.55 \text{ e } \text{\AA}^{-3}$ 

 $(\Delta/\sigma)_{\rm max} = 0.001$ 

6528 reflections with  $I > 2\sigma(I)$ 

Mo  $K\alpha$  radiation

 $\mu = 0.47 \text{ mm}^{-1}$ 

T = 173 (2) K

Prism, orange

 $R_{\rm int} = 0.027$ 

 $\theta_{\rm max} = 25.0^{\circ}$ 

#### Crystal data

 $\begin{bmatrix} \text{Ti}(C_6\text{F}_5)_2(\text{C}_{14}\text{H}_{42}\text{O}_2\text{Si}_7) \end{bmatrix} \\ M_r = 821.13 \\ \text{Monoclinic, } P_{2_1}/c \\ a = 11.3299 (2) \\ \text{Å} \\ b = 19.1104 (3) \\ \text{Å} \\ c = 19.7235 (4) \\ \text{Å} \\ \beta = 102.039 (1)^{\circ} \\ V = 4176.58 (13) \\ \text{Å}^3 \end{bmatrix}$ 

#### Data collection

Bruker X8-APEX CCD diffractometer  $\varphi$  and  $\omega$  scans Absorption correction: none 45244 measured reflections

#### Refinement

Refinement on  $F^2$   $R[F^2 > 2\sigma(F^2)] = 0.036$   $wR(F^2) = 0.099$  S = 1.087359 reflections 429 parameters H-atom parameters constrained

#### Table 1

Selected geometric parameters (Å, °).

Ti1-O2	1.7408 (15)	Si2-O1	1.7127 (15)
Ti1-O1	1.7503 (15)	Si2-Si3	2.3869 (9)
Ti1-C15	2.135 (2)	Si3-Si4	2.3753 (9)
Ti1-C21	2.136 (2)	Si4-O2	1.7125 (15)
Si1-Si2	2.3540 (8)		. ,
O2-Ti1-O1	106.33 (7)	O1-Ti1-C15	111.75 (8)
O2-Ti1-C15	109.77 (8)	O1-Ti1-C21	111.43 (9)
O2-Ti1-C21	108.35 (8)	C15-Ti1-C21	109.12 (9)
O1-Si2-Si3-Si4	-9.90 (7)	Si2-Si3-Si4-O2	6.83 (7)

All H atoms were initially located in a difference Fourier map. They were then constrained to an ideal geometry with a C-H



### Figure 1

**Fig. 1.** The molecular structure of (2), showing the atom-labelling scheme. Displacement ellipsoids are drawn at the 30% probability level. H atoms are omitted for clarity.

distance of 0.98 Å and  $U_{\rm iso}$  (H) = 1.5 $U_{\rm eq}$ (C), but each group was allowed to rotate freely about its C–Si bond.

Data collection: *SMART* (Bruker, 1998); cell refinement: *SAINT* (Bruker, 1998); data reduction: *SAINT*; program(s) used to solve structure: *SHELXTL* (Sheldrick, 2000); program(s) used to refine structure: *SHELXTL*; molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*.

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